

Search Notes

Application/Control No.

10/022,730

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

JAE SANG CHA

Art Unit

2634

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 375 | 130 | 2/23/2005 | EMF |
| 375 | 140 | 2/23/2005 | EMF |
| 375 | 145 | 2/23/2005 | EMF |
| 375 | 149 | 2/23/2005 | EMF |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM | 2/23/2005 | EMF |
| PALM INVENTORSHIP | 2/23/2005 | EMF |
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